

Pablo N. Tran

2618

SEARCHED			
Class	Subclass	Date	Examiner
455	426.1	03/14/16	JD
	403		
	572		
	422		
	428		
	522		
	424		
	523		
	454		
	414.1		
	418		
	450		
	444		
	560-961		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

[illegible]

Search Notes (continued)


Application/Control No.

10/651,185

Examiner

Pablo N. Tran

 Applicant(s)/Patent under
Reexamination

HAUER, MARTIN

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
495	402.1	03/14/00	gl
	300		
	460		
370	338		
	347		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR